NGD8201B

Ignition IGBT, 20 A, 400 V

N−Channel DPAK

This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Over−Voltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

Features

- Ideal for Coil−on−Plug Applications
- DPAK Package Offers Smaller Footprint for Increased Board Space
- Gate−Emitter ESD Protection
- Temperature Compensated Gate−Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- New Design Increases Unclamped Inductive Switching (UIS) Energy Per Area
- Low Threshold Voltage Interfaces Power Loads to Logic or Microprocessor Devices
- Low Saturation Voltage
- High Pulsed Current Capability
- Emitter Ballasting for Short−Circuit Capability
- These are Pb−Free Devices

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Collector−Emitter Voltage	V_{CES}	430	V_{DC}
Collector−Gate Voltage	V_{CER}	430	V_{DC}
Gate−Emitter Voltage	V_{GE}	18	V_{DC}
Collector Current−Continuous @ T_C = 25°C − Pulsed	I_C	15 50	A_{DC} A_{AC}
ESD (Human Body Model) R = 1500 Ω, C = 100 pF	ESD	8.0	kV
ESD (Machine Model) R = 0 Ω, C = 200 pF	ESD	800	V
Total Power Dissipation @ T_C = 25°C Derate above 25°C	P_D	115 0.77	Watts W/°C
Operating and Storage Temperature Range	T_J, T_{stg}	−55 to +175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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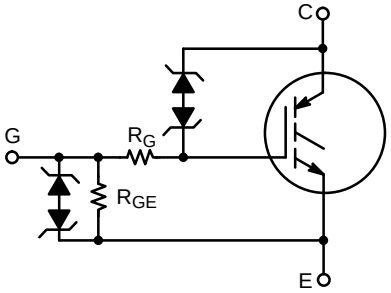
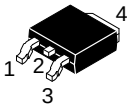
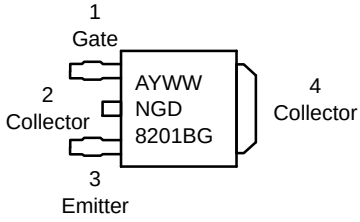
20 AMPS, 400 VOLTS
$V_{CE(on)}$ ≤ 1.8 V @
I_C = 10 A, V_{GE} ≥ 4.5 V





DPAK
CASE 369C
STYLE 7

MARKING DIAGRAM



NGD8201B = Device Code
A = Assemlby Location
Y = Year
WW = Work Week
G = Pb−Free Device

ORDERING INFORMATION

Device	Package	Shipping†
NGD8201BNT4G	DPAK (Pb−Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

UNCLAMPED COLLECTOR−TO−EMITTER AVALANCHE CHARACTERISTICS ($-55° \le T_J \le 175°C$)

Characteristic	Symbol	Value	Unit
Single Pulse Collector−to−Emitter Avalanche Energy V_{CC} = 50 V, V_{GE} = 5.0 V, Pk I_L = 22 A, L = 1.8 mH, Starting T_J = 25°C V_{CC} = 50 V, V_{GE} = 5.0 V, Pk I_L = 17 A, L = 3.0 mH, Starting T_J = 25°C V_{CC} = 50 V, V_{GE} = 5.0 V, Pk I_L = 19 A, L = 1.8 mH, Starting T_J = 125°C	E_{AS}	 435 433 325	mJ
Reverse Avalanche Energy V_{CC} = 100 V, V_{GE} = 20 V, Pk I_L = 25.8 A, L = 6.0 mH, Starting T_J = 25°C	$E_{AS(R)}$	 2000	mJ

THERMAL CHARACTERISTICS

Thermal Resistance, Junction to Case		$R_{\theta JC}$	1.3	°C/W
Thermal Resistance, Junction to Ambient	DPAK (Note 1)	$R_{\theta JA}$	95	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8″ from case for 5 seconds		T_L	275	°C

1. When surface mounted to an FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Test Conditions	Temperature	Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Collector−Emitter Clamp Voltage	BV_{CES}	I_C = 2.0 mA	T_J = −40°C to 150°C	380	395	420	V_{DC}
		I_C = 10 mA	T_J = −40°C to 150°C	390	405	430	
Zero Gate Voltage Collector Current	I_{CES}	V_{CE} = 350 V, V_{GE} = 0 V	T_J = 25°C	−	1.5	5	μA_{DC}
			T_J = 150°C	−	10	30*	
			T_J = −40°C	−	0.5	2.5	
		V_{CE} = 15 V, V_{GE} = 0 V	T_J = 25°C	−	−	2.0	
Reverse Collector−Emitter Leakage Current	I_{ECS}	V_{CE} = −24 V	T_J = 25°C	−	0.7	1.0	mA
			T_J = 150°C	−	12	25*	
			T_J = −40°C	−	0.1	1.0	
Reverse Collector−Emitter Clamp Voltage	$B_{VCES(R)}$	I_C = −75 mA	T_J = 25°C	27	33	37	V_{DC}
			T_J = 150°C	30	36	40	
			T_J = −40°C	25	32	35	
Gate−Emitter Clamp Voltage	BV_{GES}	I_G = 5.0 mA	T_J = −40°C to 150°C	11	13	15	V_{DC}
Gate−Emitter Leakage Current	I_{GES}	V_{GE} = 10 V	T_J = −40°C to 150°C	384	640	700	μA_{DC}
Gate Resistor	R_G	–	T_J = −40°C to 150°C	−	70	−	Ω
Gate Emitter Resistor (Note 3)	R_{GE}	–	T_J = −40°C to 150°C	10	16	26	kΩ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
*Maximum Value of Characteristic across Temperature Range.

ELECTRICAL CHARACTERISTICS (continued)

Characteristic	Symbol	Test Conditions	Temperature	Min	Typ	Max	Unit
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	$V_{GE(th)}$	I_C = 1.0 mA, V_{GE} = V_{CE}	T_J = 25°C	1.2	1.5	1.8	V_{DC}
			T_J = 150°C	0.8	1.0	1.3	
			T_J = −40°C	1.4	1.7	2.0*	
Threshold Temperature Coefficient (Negative)	–	–	–	–	3.4	–	mV/°C
Collector−to−Emitter On−Voltage	$V_{CE(on)}$	I_C = 6.0 A, V_{GE} = 4.0 V	T_J = 25°C	1.0	1.2	1.5	V_{DC}
			T_J = 150°C	1.0	1.2	1.5	
			T_J = −40°C	1.0	1.2	1.5*	
		I_C = 8.0 A, V_{GE} = 4.0 V	T_J = 25°C	1.2	1.4	1.6*	
			T_J = 150°C	1.2	1.4	1.6	
			T_J = −40°C	1.2	1.4	1.6*	
		I_C = 10 A, V_{GE} = 4.0 V	T_J = 25°C	1.3	1.5	1.8	
			T_J = 150°C	1.3	1.5	1.9	
			T_J = −40°C	1.3	1.6	1.8*	
		I_C = 15 A, V_{GE} = 4.0 V	T_J = 25°C	1.7	1.9	2.3	
			T_J = 150°C	1.9	2.2	2.5*	
			T_J = −40°C	1.5	1.9	2.3	
		I_C = 10 A, V_{GE} = 4.5 V	T_J = 25°C	1.3	1.5	1.8*	
			T_J = 150°C	1.3	1.5	1.8*	
			T_J = −40°C	1.3	1.5	1.8*	
		I_C = 6.5 A, V_{GE} = 3.7 V	T_J = 25°C	–	–	1.65	
Forward Transconductance	gfs	V_{CE} = 5.0 V, I_C = 6.0 A	T_J = −40°C to 150°C	8.0	14	25	Mhos
DYNAMIC CHARACTERISTICS (Note 3)							
Input Capacitance	C_{ISS}	V_{CC} = 25 V, V_{GE} = 0 V f = 1.0 MHz	T_J = −40°C to 150°C	400	800	1000	pF
Output Capacitance	C_{OSS}			50	75	100	
Transfer Capacitance	C_{RSS}			4.0	7.0	10	
SWITCHING CHARACTERISTICS (Note 3)							
Turn−Off Delay Time (Resistive)	$t_{d(off)}$	V_{CC} = 300 V, I_C = 6.5 A R_G = 1.0 kΩ, R_L = 46 Ω,	T_J = 25°C	–	4.0	10	μSec
Fall Time (Resistive)	t_f	V_{CC} = 300 V, I_C = 6.5 A R_G = 1.0 kΩ, R_L = 46 Ω,	T_J = 25°C	–	9.0	15	
Turn−On Delay Time	$t_{d(on)}$	V_{CC} = 10 V, I_C = 6.5 A R_G = 1.0 kΩ, R_L = 1.5 Ω	T_J = 25°C	–	0.7	4.0	μSec
Rise Time	t_r	V_{CC} = 10 V, I_C = 6.5 A R_G = 1.0 kΩ, R_L = 1.5 Ω	T_J = 25°C	–	4.5	7.0	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

*Maximum Value of Characteristic across Temperature Range.

2. Pulse Test: Pulse Width ≤ 300 μS, Duty Cycle ≤ 2%.
3. Not production tested.

TYPICAL ELECTRICAL CHARACTERISTICS

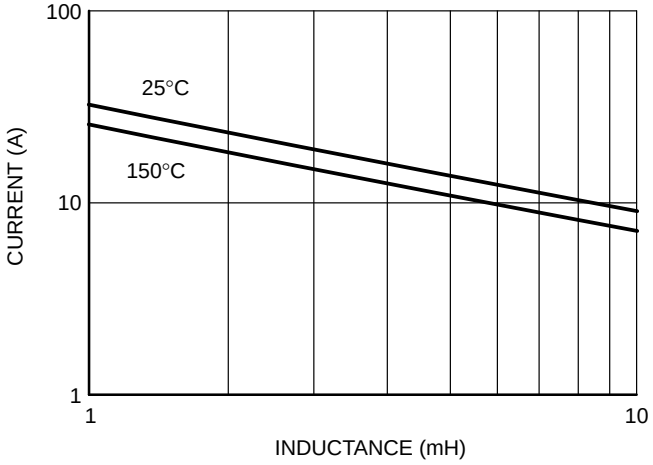


Figure 1. Maximum Single Pulse Switch Off Current vs. Inductance

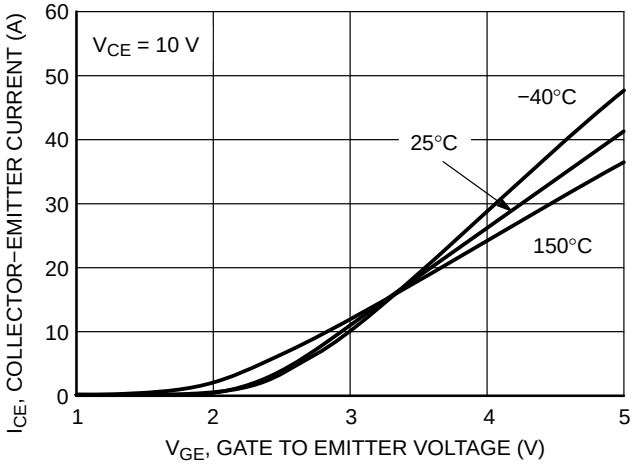


Figure 2. Transfer Characteristics

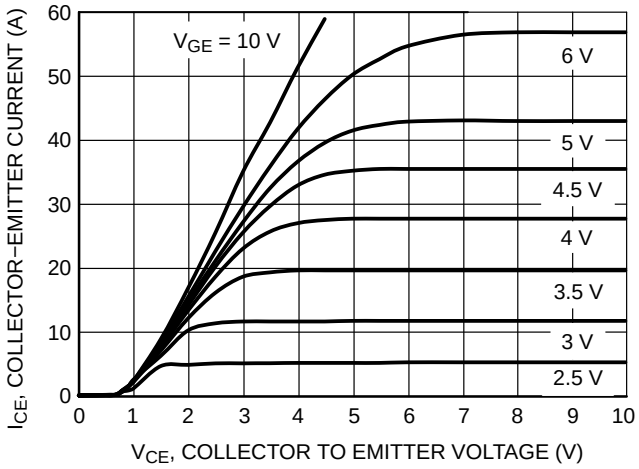


Figure 3. Output Characteristics, T_J = 25°C

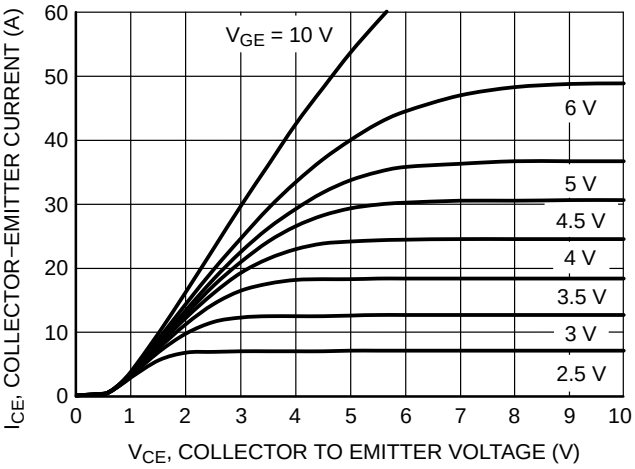


Figure 4. On−Region Characteristics, T_J = 150°C

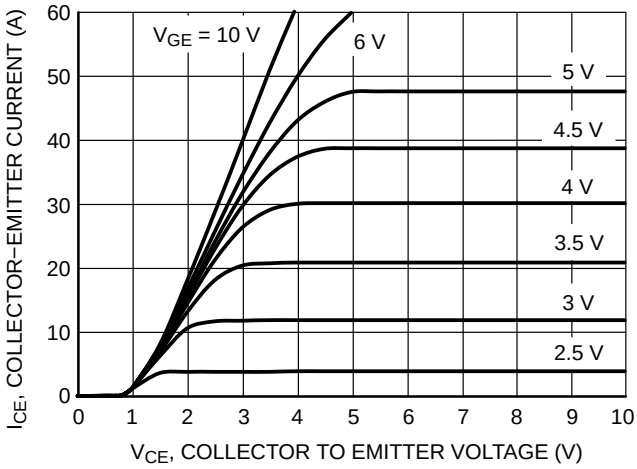


Figure 5. On−Region Characteristics, T_J = −40°C

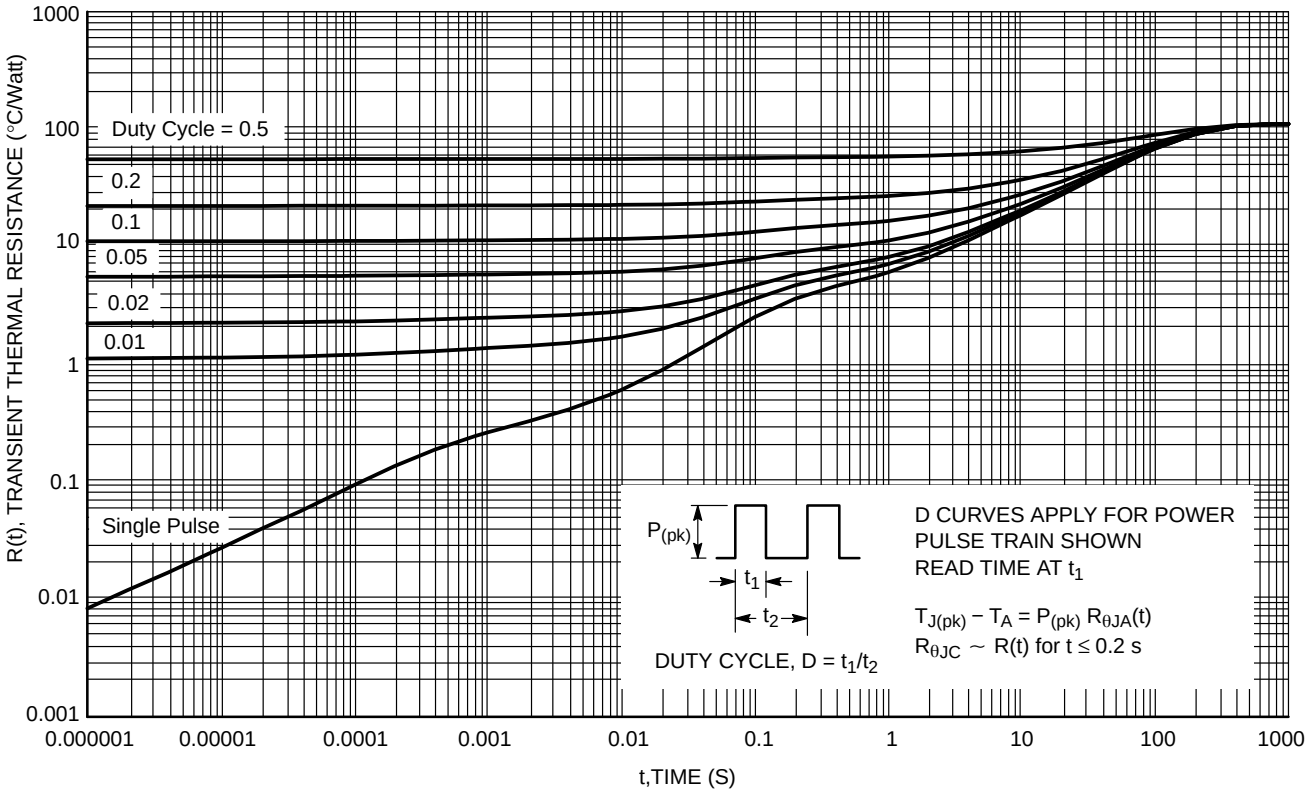
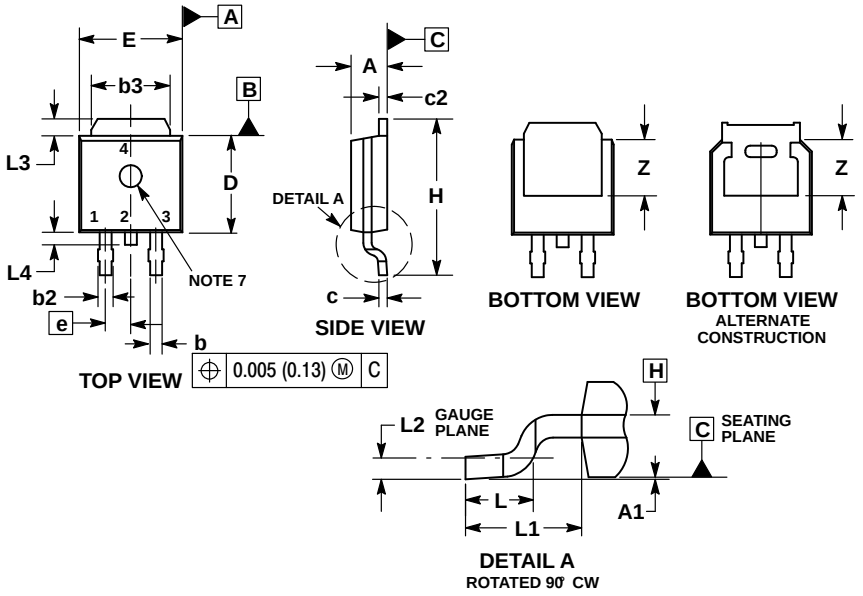


Figure 6. Transient Thermal Resistance (Non−normalized Junction−to−Ambient mounted on minimum pad area)

PACKAGE DIMENSIONS

DPAK
CASE 369C
ISSUE E

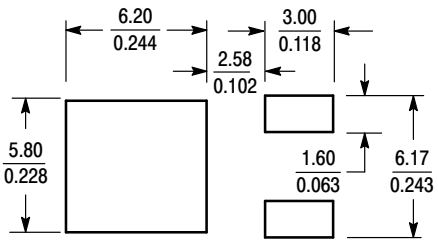


NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: INCHES.
3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
c	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
e	0.090 BSC		2.29 BSC	
H	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114 REF		2.90 REF	
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4	−−−	0.040	−−−	1.01
Z	0.155	−−−	3.93	−−−

STYLE 7:
PIN 1. GATE
2. COLLECTOR
3. EMITTER
4. COLLECTOR

SOLDERING FOOTPRINT*



SCALE 3:1 (mm / inches)

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
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